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**Embedded - Microcontrollers - Application Specific** represents a category of microcontrollers designed with unique features and capabilities tailored to specific application needs. Unlike general-purpose microcontrollers, application-specific microcontrollers are optimized for particular tasks, offering enhanced performance, efficiency, and functionality to meet the demands of specialized applications.

**What Are Embedded - Microcontrollers - Application Specific?**

Application specific microcontrollers are engineered to

#### Details

Product Status	Obsolete
Applications	HB LED Controller
Core Processor	M8C
Program Memory Type	FLASH (16KB)
Controller Series	CY8CLED
RAM Size	1K x 8
Interface	I <sup>2</sup> C, SPI, UART/USART, USB
Number of I/O	56
Voltage - Supply	3V ~ 5.25V
Operating Temperature	-40°C ~ 85°C
Mounting Type	Surface Mount
Package / Case	68-VFQFN Exposed Pad
Supplier Device Package	68-QFN (8x8)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/infineon-technologies/cy8cled04-68lfxi">https://www.e-xfl.com/product-detail/infineon-technologies/cy8cled04-68lfxi</a>



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## Getting Started

The quickest way to understand PSoC silicon is to read this data sheet and then use the PSoC Designer integrated development environment (IDE). This data sheet is an overview of the PSoC integrated circuit and presents specific pin, register, and electrical specifications.

For in depth information, along with detailed programming details, see the [PSoC® Programmable System-on-Chip Technical Reference Manual](#).

For up-to-date ordering, packaging, and electrical specification information, see the latest PSoC device data sheets on the web at <http://www.cypress.com/ez-color>.

## Application Notes

[Cypress application notes](#) are an excellent introduction to the wide variety of possible PSoC designs.

## Development Kits

[PSoC Development Kits](#) are available online from and through a growing number of regional and global distributors, which include Arrow, Avnet, Digi-Key, Farnell, Future Electronics, and Newark.

## Training

[Free PSoC technical training](#) (on demand, webinars, and workshops), which is available online via [www.cypress.com](http://www.cypress.com), covers a wide variety of topics and skill levels to assist you in your designs.

## CYPros Consultants

Certified PSoC consultants offer everything from technical assistance to completed PSoC designs. To contact or become a PSoC consultant go to the [CYPros Consultants](#) web site.

## Solutions Library

Visit our growing [library of solution focused designs](#). Here you can find various application designs that include firmware and hardware design files that enable you to complete your designs quickly.

## Technical Support

[Technical support](#) – including a searchable Knowledge Base articles and technical forums – is also available online. If you cannot find an answer to your question, call our Technical Support hotline at 1-800-541-4736.

## Development Tools

PSoC Designer™ is the revolutionary integrated design environment (IDE) that you can use to customize PSoC to meet your specific application requirements. PSoC Designer software accelerates system design and time to market. Develop your applications using a library of precharacterized analog and digital peripherals (called user modules) in a drag-and-drop design environment. Then, customize your design by leveraging the dynamically generated application programming interface (API) libraries of code. Finally, debug and test your designs with the integrated debug environment, including in-circuit emulation and standard software debug features. PSoC Designer includes:

- Application editor graphical user interface (GUI) for device and user module configuration and dynamic reconfiguration
- Extensive user module catalog
- Integrated source-code editor (C and assembly)
- Free C compiler with no size restrictions or time limits
- Built-in debugger
- In-circuit emulation
- Built-in support for communication interfaces:
  - Hardware and software I<sup>2</sup>C slaves and masters
  - Full-speed USB 2.0
  - Up to four full-duplex universal asynchronous receiver/transmitters (UARTs), SPI master and slave, and wireless

PSoC Designer supports the entire library of PSoC 1 devices and runs on Windows XP, Windows Vista, and Windows 7.

## PSoC Designer Software Subsystems

### Design Entry

In the chip-level view, choose a base device to work with. Then select different onboard analog and digital components that use the PSoC blocks, which are called user modules. Examples of user modules are analog-to-digital converters (ADCs), digital-to-analog converters (DACs), amplifiers, and filters. Configure the user modules for your chosen application and connect them to each other and to the proper pins. Then generate your project. This prepopulates your project with APIs and libraries that you can use to program your application.

The tool also supports easy development of multiple configurations and dynamic reconfiguration. Dynamic reconfiguration makes it possible to change configurations at run time. In essence, this lets you to use more than 100 percent of PSoC's resources for an application.



**Table 3. Register Map Bank 0 Table: User Space (continued)**

Name	Addr (0,Hex)	Access	Name	Addr (0,Hex)	Access	Name	Addr (0,Hex)	Access	Name	Addr (0,Hex)	Access
DBB00DR2	22	RW		62			A2		INT_VC	E2	RC
DBB00CR0	23	#	ARF_CR	63	RW		A3		RES_WDT	E3	W
DBB01DR0	24	#	CMP_CR0	64	#		A4		DEC_DH	E4	RC
DBB01DR1	25	W	ASY_CR	65	#		A5		DEC_DL	E5	RC
DBB01DR2	26	RW	CMP_CR1	66	RW		A6		DEC_CR0	E6	RW
DBB01CR0	27	#		67			A7		DEC_CR1	E7	RW
DCB02DR0	28	#		68		MUL1_X	A8	W	MUL0_X	E8	W
DCB02DR1	29	W		69		MUL1_Y	A9	W	MUL0_Y	E9	W
DCB02DR2	2A	RW		6A		MUL1_DH	AA	R	MUL0_DH	EA	R
DCB02CR0	2B	#		6B		MUL1_DL	AB	R	MUL0_DL	EB	R
DCB03DR0	2C	#	TMP_DR0	6C	RW	ACC1_DR1	AC	RW	ACC0_DR1	EC	RW
DCB03DR1	2D	W	TMP_DR1	6D	RW	ACC1_DR0	AD	RW	ACC0_DR0	ED	RW
DCB03DR2	2E	RW	TMP_DR2	6E	RW	ACC1_DR3	AE	RW	ACC0_DR3	EE	RW
DCB03CR0	2F	#	TMP_DR3	6F	RW	ACC1_DR2	AF	RW	ACC0_DR2	EF	RW
	30		ACB00CR3	70	RW	RDIOI	B0	RW		F0	
	31		ACB00CR0	71	RW	RDIOISYN	B1	RW		F1	
	32		ACB00CR1	72	RW	RDIOIS	B2	RW		F2	
	33		ACB00CR2	73	RW	RDIOILT0	B3	RW		F3	
	34		ACB01CR3	74	RW	RDIOILT1	B4	RW		F4	
	35		ACB01CR0	75	RW	RDIORO0	B5	RW		F5	
	36		ACB01CR1	76	RW	RDIORO1	B6	RW		F6	
	37		ACB01CR2	77	RW		B7		CPU_F	F7	RL
	38			78			B8			F8	
	39			79			B9			F9	
	3A			7A			BA			FA	
	3B			7B			BB			FB	
	3C			7C			BC			FC	
	3D			7D			BD		DAC_D	FD	RW
	3E			7E			BE		CPU_SCR1	FE	#
	3F			7F			BF		CPU_SCR0	FF	#

Blank fields are Reserved and should not be accessed.

# Access is bit specific.

**Table 4. Register Map Bank 1 Table: Configuration Space**

Name	Addr (1,Hex)	Access	Name	Addr (1,Hex)	Access	Name	Addr (1,Hex)	Access	Name	Addr (1,Hex)	Access
PRT0DM0	00	RW	PMA0_WA	40	RW	ASC10CR0	80	RW	USB/O_CR2	C0	RW
PRT0DM1	01	RW	PMA1_WA	41	RW	ASC10CR1	81	RW	USB_CR1	C1	#
PRT0IC0	02	RW	PMA2_WA	42	RW	ASC10CR2	82	RW			
PRT0IC1	03	RW	PMA3_WA	43	RW	ASC10CR3	83	RW			
PRT1DM0	04	RW	PMA4_WA	44	RW	ASD11CR0	84	RW	EP1_CR0	C4	#
PRT1DM1	05	RW	PMA5_WA	45	RW	ASD11CR1	85	RW	EP2_CR0	C5	#
PRT1IC0	06	RW	PMA6_WA	46	RW	ASD11CR2	86	RW	EP3_CR0	C6	#
PRT1IC1	07	RW	PMA7_WA	47	RW	ASD11CR3	87	RW	EP4_CR0	C7	#
PRT2DM0	08	RW		48			88			C8	
PRT2DM1	09	RW		49			89			C9	
PRT2IC0	0A	RW		4A			8A			CA	
PRT2IC1	0B	RW		4B			8B			CB	
PRT3DM0	0C	RW		4C			8C			CC	
PRT3DM1	0D	RW		4D			8D			CD	
PRT3IC0	0E	RW		4E			8E			CE	
PRT3IC1	0F	RW		4F			8F			CF	
PRT4DM0	10	RW	PMA0_RA	50	RW		90		GDI_O_IN	D0	RW

Blank fields are Reserved and should not be accessed.

# Access is bit specific.

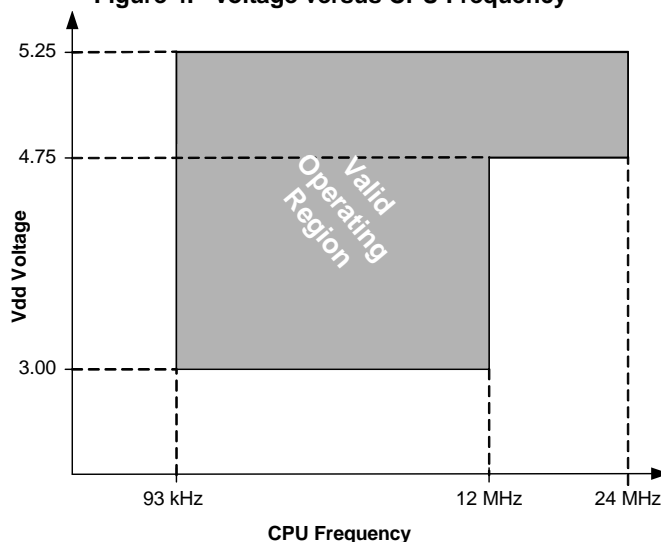


## Electrical Specifications

This section presents the DC and AC electrical specifications of the CY8CLED04 EZ-Color device. For the most up to date electrical specifications, confirm that you have the most recent data sheet by going to the web at <http://www.cypress.com/ez-color>.

Specifications are valid for  $-40\text{ }^{\circ}\text{C} \leq T_A \leq 85\text{ }^{\circ}\text{C}$  and  $T_J \leq 100\text{ }^{\circ}\text{C}$ , except where noted. Specifications for devices running at greater than 12 MHz are valid for  $-40\text{ }^{\circ}\text{C} \leq T_A \leq 70\text{ }^{\circ}\text{C}$  and  $T_J \leq 82\text{ }^{\circ}\text{C}$ .

**Figure 4. Voltage versus CPU Frequency**





**Absolute Maximum Ratings**

Symbol	Description	Min	Typ	Max	Units	Notes
$T_{STG}$	Storage temperature	-55	25	+100	°C	Higher storage temperatures will reduce data retention time. Recommended storage temperature is +25 °C ± 25 °C. Extended duration storage temperatures above 65 °C will degrade reliability.
$T_A$	Ambient temperature with power applied	-40	–	+85	°C	
$V_{DD}$	Supply voltage on $V_{DD}$ relative to $V_{SS}$	-0.5	–	+6.0	V	
$V_{I/O}$	DC input voltage	$V_{SS} - 0.5$	–	$V_{DD} + 0.5$	V	
$V_{I/O2}$	DC voltage applied to tri-state	$V_{SS} - 0.5$	–	$V_{DD} + 0.5$	V	
$I_{MI/O}$	Maximum current into any port pin	-25	–	+50	mA	
$I_{MAI/O}$	Maximum current into any port pin configured as analog driver	-50	–	+50	mA	
ESD	Electrostatic discharge voltage	2000	–	–	V	Human Body Model ESD.
LU	Latch-up current	–	–	200	mA	

**Operating Temperature**

Symbol	Description	Min	Typ	Max	Units	Notes
$T_A$	Ambient temperature	-40	–	+85	°C	
$T_{AUSB}$	Ambient temperature using USB	-10	–	+85	°C	
$T_J$	Junction temperature	-40	–	+100	°C	The temperature rise from ambient to junction is package specific. See <a href="#">“Thermal Impedance”</a> on page 38. The user must limit the power consumption to comply with this requirement.



### DC Low Power Comparator Specifications

The following table lists guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and  $-40\text{ }^{\circ}\text{C} \leq T_A \leq 85\text{ }^{\circ}\text{C}$ , 3.0 V to 3.6 V and  $-40\text{ }^{\circ}\text{C} \leq T_A \leq 85\text{ }^{\circ}\text{C}$ , or 2.4 V to 3.0 V and  $-40\text{ }^{\circ}\text{C} \leq T_A \leq 85\text{ }^{\circ}\text{C}$ , respectively. Typical parameters are measured at 5 V at 25  $^{\circ}\text{C}$  and are for design guidance only.

**Table 9. DC Low Power Comparator Specifications**

Symbol	Description	Min	Typ	Max	Units	Notes
$V_{REFLPC}$	Low power comparator (LPC) reference voltage range	0.2	–	$V_{DD} - 1$	V	
$I_{SLPC}$	LPC supply current	–	10	40	$\mu\text{A}$	
$V_{OSLPC}$	LPC voltage offset	–	2.5	30	mV	

### DC Analog Output Buffer Specifications

The following tables list guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and  $-40\text{ }^{\circ}\text{C} \leq T_A \leq 85\text{ }^{\circ}\text{C}$ , or 3.0 V to 3.6 V and  $-40\text{ }^{\circ}\text{C} \leq T_A \leq 85\text{ }^{\circ}\text{C}$ , respectively. Typical parameters are measured at 5 V and 3.3 V at 25  $^{\circ}\text{C}$  and are for design guidance only.

**Table 10. 5-V DC Analog Output Buffer Specifications**

Symbol	Description	Min	Typ	Max	Units	Notes
$C_L$	Load capacitance	–	–	200	pF	This specification applies to the external circuit that is being driven by the analog output buffer.
$V_{OSOB}$	Input offset voltage (absolute value)	–	3	12	mV	
$TCV_{OSOB}$	Average input offset voltage drift	–	+6	–	$\mu\text{V}/^{\circ}\text{C}$	
$V_{CMOB}$	Common mode input voltage range	0.5	–	$V_{DD} - 1.0$	V	
$R_{OUTOB}$	Output resistance					
	Power = low	–	0.6	–	W	
	Power = high	–	0.6	–	W	
$V_{OHIGHOB}$	High output voltage swing (Load = 32 ohms to $V_{DD}/2$ )					
		Power = low	$0.5 \times V_{DD} + 1.1$	–	V	
		Power = high	$0.5 \times V_{DD} + 1.1$	–	V	
$V_{OLOWOB}$	Low output voltage swing (Load = 32 ohms to $V_{DD}/2$ )					
		Power = low	–	$0.5 \times V_{DD} - 1.3$	V	
		Power = high	–	$0.5 \times V_{DD} - 1.3$	V	
$I_{SOB}$	Supply current including opamp bias cell (No Load)					
		Power = low	1.1	5.1	mA	
		Power = high	2.6	8.8	mA	
$PSRR_{OB}$	Supply voltage rejection ratio	53	64	–	dB	$(0.5 \times V_{DD} - 1.3) \leq V_{OUT} \leq (V_{DD} - 2.3)$ .



**Table 13. 3.3-V DC Analog Reference Specifications**

Reference ARF_CR [5:3]	Reference Power Settings	Symbol	Reference	Description	Min	Typ	Max	Units
0b000	RefPower = high Opamp bias = high	V <sub>REFHI</sub>	Ref High	V <sub>DD</sub> /2 + Bandgap	V <sub>DD</sub> /2 + 1.200	V <sub>DD</sub> /2 + 1.290	V <sub>DD</sub> /2 + 1.365	V
		V <sub>AGND</sub>	AGND	V <sub>DD</sub> /2	V <sub>DD</sub> /2 - 0.030	V <sub>DD</sub> /2	V <sub>DD</sub> /2 + 0.034	V
		V <sub>REFLO</sub>	Ref Low	V <sub>DD</sub> /2 - Bandgap	V <sub>DD</sub> /2 - 1.346	V <sub>DD</sub> /2 - 1.292	V <sub>DD</sub> /2 - 1.208	V
	RefPower = high Opamp bias = low	V <sub>REFHI</sub>	Ref High	V <sub>DD</sub> /2 + Bandgap	V <sub>DD</sub> /2 + 1.196	V <sub>DD</sub> /2 + 1.292	V <sub>DD</sub> /2 + 1.374	V
		V <sub>AGND</sub>	AGND	V <sub>DD</sub> /2	V <sub>DD</sub> /2 - 0.029	V <sub>DD</sub> /2	V <sub>DD</sub> /2 + 0.031	V
		V <sub>REFLO</sub>	Ref Low	V <sub>DD</sub> /2 - Bandgap	V <sub>DD</sub> /2 - 1.349	V <sub>DD</sub> /2 - 1.295	V <sub>DD</sub> /2 - 1.227	V
	RefPower = medium Opamp bias = high	V <sub>REFHI</sub>	Ref High	V <sub>DD</sub> /2 + Bandgap	V <sub>DD</sub> /2 + 1.204	V <sub>DD</sub> /2 + 1.293	V <sub>DD</sub> /2 + 1.369	V
		V <sub>AGND</sub>	AGND	V <sub>DD</sub> /2	V <sub>DD</sub> /2 - 0.030	V <sub>DD</sub> /2	V <sub>DD</sub> /2 + 0.030	V
		V <sub>REFLO</sub>	Ref Low	V <sub>DD</sub> /2 - Bandgap	V <sub>DD</sub> /2 - 1.351	V <sub>DD</sub> /2 - 1.297	V <sub>DD</sub> /2 - 1.229	V
	RefPower = medium Opamp bias = low	V <sub>REFHI</sub>	Ref High	V <sub>DD</sub> /2 + Bandgap	V <sub>DD</sub> /2 + 1.189	V <sub>DD</sub> /2 + 1.294	V <sub>DD</sub> /2 + 1.384	V
		V <sub>AGND</sub>	AGND	V <sub>DD</sub> /2	V <sub>DD</sub> /2 - 0.032	V <sub>DD</sub> /2	V <sub>DD</sub> /2 + 0.029	V
		V <sub>REFLO</sub>	Ref Low	V <sub>DD</sub> /2 - Bandgap	V <sub>DD</sub> /2 - 1.353	V <sub>DD</sub> /2 - 1.297	V <sub>DD</sub> /2 - 1.230	V
0b001	RefPower = high Opamp bias = high	V <sub>REFHI</sub>	Ref High	P2[4]+P2[6] (P2[4] = V <sub>DD</sub> /2, P2[6] = 0.5 V)	P2[4] + P2[6] - 0.105	P2[4] + P2[6] - 0.008	P2[4] + P2[6] + 0.095	V
		V <sub>AGND</sub>	AGND	P2[4]	P2[4]	P2[4]	P2[4]	—
		V <sub>REFLO</sub>	Ref Low	P2[4]-P2[6] (P2[4] = V <sub>DD</sub> /2, P2[6] = 0.5 V)	P2[4] - P2[6] - 0.035	P2[4] - P2[6] + 0.006	P2[4] - P2[6] + 0.053	V
	RefPower = high Opamp bias = low	V <sub>REFHI</sub>	Ref High	P2[4]+P2[6] (P2[4] = V <sub>DD</sub> /2, P2[6] = 0.5 V)	P2[4] + P2[6] - 0.094	P2[4] + P2[6] - 0.005	P2[4] + P2[6] + 0.073	V
		V <sub>AGND</sub>	AGND	P2[4]	P2[4]	P2[4]	P2[4]	—
		V <sub>REFLO</sub>	Ref Low	P2[4]-P2[6] (P2[4] = V <sub>DD</sub> /2, P2[6] = 0.5 V)	P2[4] - P2[6] - 0.033	P2[4] - P2[6] + 0.002	P2[4] - P2[6] + 0.042	V
	RefPower = medium Opamp bias = high	V <sub>REFHI</sub>	Ref High	P2[4]+P2[6] (P2[4] = V <sub>DD</sub> /2, P2[6] = 0.5 V)	P2[4] + P2[6] - 0.094	P2[4] + P2[6] - 0.003	P2[4] + P2[6] + 0.075	V
		V <sub>AGND</sub>	AGND	P2[4]	P2[4]	P2[4]	P2[4]	—
		V <sub>REFLO</sub>	Ref Low	P2[4]-P2[6] (P2[4] = V <sub>DD</sub> /2, P2[6] = 0.5 V)	P2[4] - P2[6] - 0.035	P2[4] - P2[6]	P2[4] - P2[6] + 0.038	V
	RefPower = medium Opamp bias = low	V <sub>REFHI</sub>	Ref High	P2[4]+P2[6] (P2[4] = V <sub>DD</sub> /2, P2[6] = 0.5 V)	P2[4] + P2[6] - 0.095	P2[4] + P2[6] - 0.003	P2[4] + P2[6] + 0.080	V
		V <sub>AGND</sub>	AGND	P2[4]	P2[4]	P2[4]	P2[4]	—
		V <sub>REFLO</sub>	Ref Low	P2[4]-P2[6] (P2[4] = V <sub>DD</sub> /2, P2[6] = 0.5 V)	P2[4] - P2[6] - 0.038	P2[4] - P2[6]	P2[4] - P2[6] + 0.038	V
0b010	RefPower = high Opamp bias = high	V <sub>REFHI</sub>	Ref High	V <sub>DD</sub>	V <sub>DD</sub> - 0.119	V <sub>DD</sub> - 0.005	V <sub>DD</sub>	V
		V <sub>AGND</sub>	AGND	V <sub>DD</sub> /2	V <sub>DD</sub> /2 - 0.028	V <sub>DD</sub> /2	V <sub>DD</sub> /2 + 0.029	V
		V <sub>REFLO</sub>	Ref Low	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>SS</sub> + 0.004	V <sub>SS</sub> + 0.022	V
	RefPower = high Opamp bias = low	V <sub>REFHI</sub>	Ref High	V <sub>DD</sub>	V <sub>DD</sub> - 0.131	V <sub>DD</sub> - 0.004	V <sub>DD</sub>	V
		V <sub>AGND</sub>	AGND	V <sub>DD</sub> /2	V <sub>DD</sub> /2 - 0.028	V <sub>DD</sub> /2	V <sub>DD</sub> /2 + 0.028	V
		V <sub>REFLO</sub>	Ref Low	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>SS</sub> + 0.003	V <sub>SS</sub> + 0.021	V
	RefPower = medium Opamp bias = high	V <sub>REFHI</sub>	Ref High	V <sub>DD</sub>	V <sub>DD</sub> - 0.111	V <sub>DD</sub> - 0.003	V <sub>DD</sub>	V
		V <sub>AGND</sub>	AGND	V <sub>DD</sub> /2	V <sub>DD</sub> /2 - 0.029	V <sub>DD</sub> /2	V <sub>DD</sub> /2 + 0.028	V
		V <sub>REFLO</sub>	Ref Low	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>SS</sub> + 0.002	V <sub>SS</sub> + 0.017	V
	RefPower = medium Opamp bias = low	V <sub>REFHI</sub>	Ref High	V <sub>DD</sub>	V <sub>DD</sub> - 0.128	V <sub>DD</sub> - 0.003	V <sub>DD</sub>	V
		V <sub>AGND</sub>	AGND	V <sub>DD</sub> /2	V <sub>DD</sub> /2 - 0.029	V <sub>DD</sub> /2	V <sub>DD</sub> /2 + 0.029	V
		V <sub>REFLO</sub>	Ref Low	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>SS</sub> + 0.002	V <sub>SS</sub> + 0.019	V



### DC Programming Specifications

The following table lists guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and  $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , or 3.0 V to 3.6 V and  $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , respectively. Typical parameters are measured at 5 V and 3.3 V at 25 °C and are for design guidance only.

**Table 16. DC Programming Specifications**

Symbol	Description	Min	Typ	Max	Units	Notes
$I_{DDP}$	Supply current during programming or verify	–	15	30	mA	
$V_{ILP}$	Input low voltage during programming or verify	–	–	0.8	V	
$V_{IHP}$	Input high voltage during programming or verify	2.1	–	–	V	
$I_{ILP}$	Input current when applying $V_{ILP}$ to P1[0] or P1[1] during programming or verify	–	–	0.2	mA	Driving internal pull-down resistor.
$I_{IHP}$	Input current when applying $V_{IHP}$ to P1[0] or P1[1] during programming or Verify	–	–	1.5	mA	Driving internal pull-down resistor.
$V_{OLV}$	Output low voltage during programming or verify	–	–	$V_{SS} + 0.75$	V	
$V_{OHV}$	Output high voltage during programming or verify	$V_{DD} - 1.0$	–	$V_{DD}$	V	
Flash <sub>ENP</sub> B	Flash endurance (per block)	50,000 <sup>[6]</sup>	–	–	–	Erase/write cycles per block.
Flash <sub>ENT</sub>	Flash endurance (total) <sup>[7]</sup>	1,800,000	–	–	–	Erase/write cycles.
Flash <sub>DR</sub>	Flash data retention	10	–	–	Years	

### DC I<sup>2</sup>C Specifications

The following table lists guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and  $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , or 3.0 V to 3.6 V and  $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , respectively. Typical parameters are measured at 5 V and 3.3 V at 25 °C and are for design guidance only.

**Table 17. DC I<sup>2</sup>C Specifications<sup>[8]</sup>**

Symbol	Description	Min	Typ	Max	Units	Notes
$V_{ILI2C}$	Input low level	–	–	$0.3 \times V_{DD}$	V	3.0 V $\leq V_{DD} \leq 3.6$ V
		–	–	$0.25 \times V_{DD}$	V	4.75 V $\leq V_{DD} \leq 5.25$ V
$V_{IHI2C}$	Input high level	$0.7 \times V_{DD}$	–	–	V	3.0 V $\leq V_{DD} \leq 5.25$ V



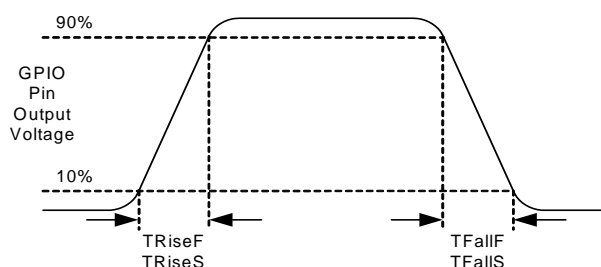
### AC GPIO Specifications

The following table lists guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and  $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , or 3.0 V to 3.6 V and  $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , respectively. Typical parameters are measured at 5 V and 3.3 V at  $25^{\circ}\text{C}$  and are for design guidance only.

**Table 19. AC GPIO Specifications**

Symbol	Description	Min	Typ	Max	Units	Notes
$F_{\text{GPIO}}$	GPIO operating frequency	0	—	12	MHz	Normal strong mode
$T_{\text{RiseF}}$	Rise time, normal strong mode, $\text{Clload} = 50 \text{ pF}$	3	—	18	ns	$V_{\text{DD}} = 4.5 \text{ to } 5.25 \text{ V}$ , 10% - 90%
$T_{\text{FallF}}$	Fall time, normal strong mode, $\text{Clload} = 50 \text{ pF}$	2	—	18	ns	$V_{\text{DD}} = 4.5 \text{ to } 5.25 \text{ V}$ , 10% - 90%
$T_{\text{RiseS}}$	Rise Time, Slow Strong Mode, $\text{Clload} = 50 \text{ pF}$	10	27	—	ns	$V_{\text{DD}} = 3 \text{ to } 5.25 \text{ V}$ , 10% - 90%
$T_{\text{FallS}}$	Fall time, slow strong mode, $\text{Clload} = 50 \text{ pF}$	10	22	—	ns	$V_{\text{DD}} = 3 \text{ to } 5.25 \text{ V}$ , 10% - 90%

**Figure 5. GPIO Timing Diagram**



### AC Full-Speed USB Specifications

The following table lists guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and  $-10^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , or 3.0 V to 3.6 V and  $-10^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , respectively. Typical parameters are measured at 5 V and 3.3 V at  $25^{\circ}\text{C}$  and are for design guidance only.

**Table 20. AC Full-Speed (12 Mbps) USB Specifications**

Symbol	Description	Min	Typ	Max	Units	Notes
$T_{\text{RFS}}$	Transition rise time	4	—	20	ns	For 50 pF load.
$T_{\text{FSS}}$	Transition fall time	4	—	20	ns	For 50 pF load.
$T_{\text{RFMFS}}$	Rise/fall time matching: $(T_R/T_F)$	90	—	111	%	For 50 pF load.
$T_{\text{DRATEFS}}$	Full-speed data rate	$12 - 0.25\%$	12	$12 + 0.25\%$	Mbps	



### AC Operational Amplifier Specifications

The following tables list guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and  $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , or 3.0 V to 3.6 V and  $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , respectively. Typical parameters are measured at 5 V and 3.3 V at  $25^{\circ}\text{C}$  and are for design guidance only.

Settling times, slew rates, and gain bandwidth are based on the analog continuous time PSoC block.

Power = High and Opamp Bias = High is not supported at 3.3 V.

**Table 21. 5-V AC Operational Amplifier Specifications**

Symbol	Description	Min	Typ	Max	Units	Notes
$T_{ROA}$	Rising settling time from 80% of DV to 0.1% of DV (10 pF load, unity gain)	—	—	3.9	ms	
	Power = Low, opamp bias = Low	—	—	0.72	ms	
	Power = Medium, opamp bias = High	—	—	0.62	ms	
	Power = High, opamp bias = High	—	—	0.62	ms	
$T_{SOA}$	Falling settling time from 20% of DV to 0.1% of DV (10 pF load, unity gain)	—	—	5.9	ms	
	Power = Low, opamp bias = Low	—	—	0.92	ms	
	Power = Medium, opamp bias = High	—	—	0.72	ms	
	Power = High, opamp bias = High	—	—	0.72	ms	
$SR_{ROA}$	Rising slew rate (20% to 80%)(10 pF load, unity gain)	0.15	—	—	V/ms	
	Power = Low, opamp bias = Low	1.7	—	—	V/ms	
	Power = Medium, opamp bias = High	6.5	—	—	V/ms	
	Power = High, opamp bias = High	6.5	—	—	V/ms	
$SR_{FOA}$	Falling slew rate (20% to 80%)(10 pF load, unity gain)	0.01	—	—	V/ms	
	Power = Low, opamp bias = Low	0.5	—	—	V/ms	
	Power = Medium, opamp bias = High	4.0	—	—	V/ms	
	Power = High, opamp bias = High	4.0	—	—	V/ms	
$BW_{OA}$	Gain bandwidth product	0.75	—	—	MHz	
	Power = Low, opamp bias = Low	3.1	—	—	MHz	
	Power = Medium, opamp bias = High	5.4	—	—	MHz	
	Power = High, opamp bias = High	5.4	—	—	MHz	
$E_{NOA}$	Noise at 1 kHz (Power = Medium, opamp bias = High)	—	100	—	nV/rt-Hz	

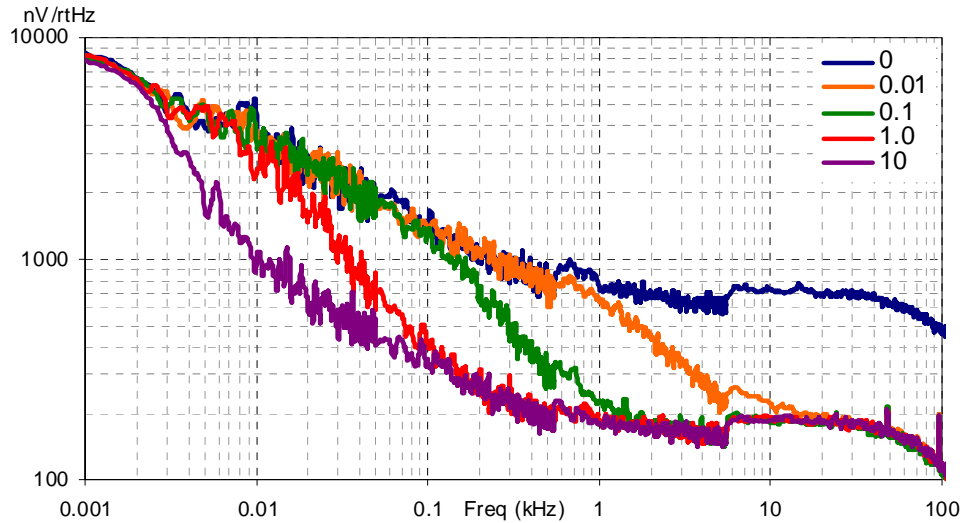
**Table 22. 3.3-V AC Operational Amplifier Specifications**

Symbol	Description	Min	Typ	Max	Units	Notes
$T_{ROA}$	Rising settling time from 80% of $\Delta V$ to 0.1% of $\Delta V$ (10 pF load, unity gain)	—	—	3.92	$\mu\text{s}$	
	Power = Low, opamp bias = Low	—	—	0.72	$\mu\text{s}$	
	Power = Medium, opamp bias = High	—	—	0.72	$\mu\text{s}$	
$T_{SOA}$	Falling settling time from 20% of $\Delta V$ to 0.1% of $\Delta V$ (10 pF load, unity gain)	—	—	5.41	$\mu\text{s}$	
	Power = Low, opamp bias = Low	—	—	0.72	$\mu\text{s}$	
	Power = Medium, Opamp Bias = High	—	—	0.72	$\mu\text{s}$	
$SR_{ROA}$	Rising slew rate (20% to 80%)(10 pF load, unity gain)	0.31	—	—	V/ $\mu\text{s}$	
	Power = Low, opamp bias = Low	2.7	—	—	V/ $\mu\text{s}$	
	Power = Medium, opamp bias = High	2.7	—	—	V/ $\mu\text{s}$	
$SR_{FOA}$	Falling slew rate (20% to 80%)(10 pF load, unity gain)	0.24	—	—	V/ $\mu\text{s}$	
	Power = Low, opamp bias = Low	1.8	—	—	V/ $\mu\text{s}$	
	Power = Medium, opamp bias = High	1.8	—	—	V/ $\mu\text{s}$	
$BW_{OA}$	Gain bandwidth product	0.67	—	—	MHz	
	Power = Low, opamp bias = Low	2.8	—	—	MHz	
	Power = Medium, opamp bias = High	2.8	—	—	MHz	
$E_{NOA}$	Noise at 1 kHz (Power = Medium, opamp bias = High)	—	100	—	nV/rt-Hz	



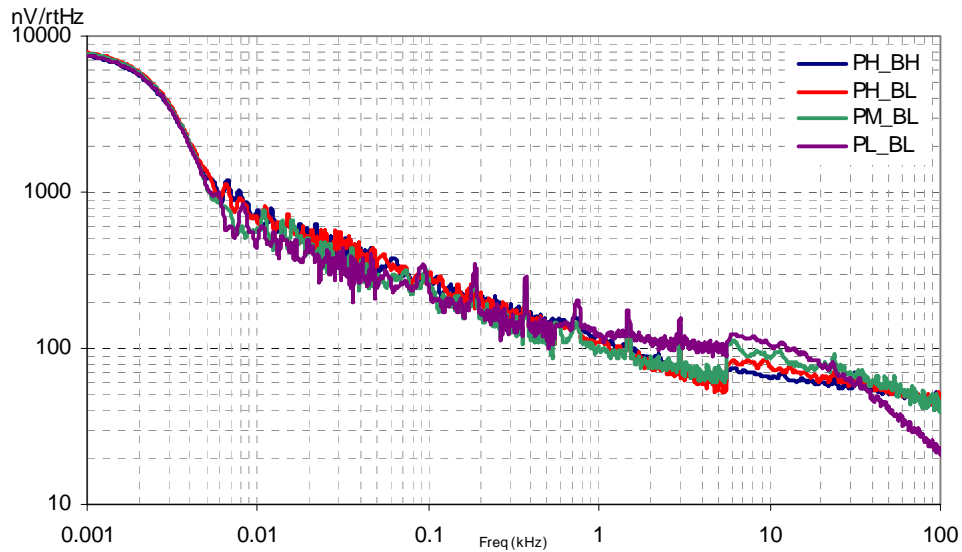
When bypassed by a capacitor on P2[4], the noise of the analog ground signal distributed to each block is reduced by a factor of up to 5 (14 dB). This is at frequencies above the corner frequency defined by the on-chip 8.1k resistance and the external capacitor.

**Figure 6. Typical AGND Noise with P2[4] Bypass**



At low frequencies, the opamp noise is proportional to  $1/f$ , power independent, and determined by device geometry. At high frequencies, increased power level reduces the noise spectrum level.

**Figure 7. Typical Opamp Noise**





### AC Low Power Comparator Specifications

The following table lists guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and  $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , 3.0 V to 3.6 V and  $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , or 2.4 V to 3.0 V and  $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , respectively. Typical parameters are measured at 5 V at  $25^{\circ}\text{C}$  and are for design guidance only.

**Table 23. AC Low Power Comparator Specifications**

Symbol	Description	Min	Typ	Max	Units	Notes
$T_{RLPC}$	LPC response time	–	–	50	$\mu\text{s}$	$\geq 50$ mV overdrive comparator reference set within $V_{REFLPC}$ .

### AC Digital Block Specifications

The following table lists guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and  $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , or 3.0 V to 3.6 V and  $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , respectively. Typical parameters are measured at 5 V and 3.3 V at  $25^{\circ}\text{C}$  and are for design guidance only.

**Table 24. AC Digital Block Specifications**

Function	Description	Min	Typ	Max	Unit	Notes
All functions	Block input clock frequency					
	$V_{DD} \geq 4.75$ V	–	–	49.92	MHz	
	$V_{DD} < 4.75$ V	–	–	25.92	MHz	
Timer	Input clock frequency					
	No capture, $V_{DD} \geq 4.75$ V	–	–	49.92	MHz	
	No capture, $V_{DD} < 4.75$ V	–	–	25.92	MHz	
	With capture	–	–	25.92	MHz	
	Capture pulse width	50 <sup>[11]</sup>	–	–	ns	
Counter	Input clock frequency					
	No enable input, $V_{DD} \geq 4.75$ V	–	–	49.92	MHz	
	No enable input, $V_{DD} < 4.75$ V	–	–	25.92	MHz	
	With enable input	–	–	25.92	MHz	
	Enable input pulse width	50 <sup>[11]</sup>	–	–	ns	
	Kill pulse width					
	Asynchronous restart mode	20	–	–	ns	
	Synchronous restart mode	50 <sup>[11]</sup>	–	–	ns	
	Disable mode	50 <sup>[11]</sup>	–	–	ns	
	Input clock frequency					
	$V_{DD} \geq 4.75$ V	–	–	49.92	MHz	
	$V_{DD} < 4.75$ V	–	–	25.92	MHz	
CRCPRS (PRS Mode)	Input clock frequency					
	$V_{DD} \geq 4.75$ V	–	–	49.92	MHz	
	$V_{DD} < 4.75$ V	–	–	25.92	MHz	
CRCPRS (CRC Mode)	Input clock frequency	–	–	24.6	MHz	
SPIM	Input clock frequency	–	–	8.2	MHz	The SPI serial clock (SCLK) frequency is equal to the input clock frequency divided by 2.
SPIS	Input clock (SCLK) frequency	–	–	4.1	MHz	The input clock is the SPI SCLK in SPIS mode.
	Width of SS_negated between transmissions	50 <sup>[11]</sup>	–	–	ns	

#### Note

11. 50 ns minimum input pulse width is based on the input synchronizers running at 24 MHz (42 ns nominal period).



**Table 24. AC Digital Block Specifications** (continued)

Function	Description	Min	Typ	Max	Unit	Notes
Transmitter	Input clock frequency					The baud rate is equal to the input clock frequency divided by 8.
	$V_{DD} \geq 4.75$ V, 2 stop bits	–	–	49.92	MHz	
	$V_{DD} \geq 4.75$ V, 1 stop bit	–	–	24.6	MHz	
	$V_{DD} < 4.75$ V	–	–	24.6	MHz	
Receiver	Input clock frequency					The baud rate is equal to the input clock frequency divided by 8.
	$V_{DD} \geq 4.75$ V, 2 stop bits	–	–	49.92	MHz	
	$V_{DD} \geq 4.75$ V, 1 stop bit	–	–	24.6	MHz	
	$V_{DD} < 4.75$ V	–	–	24.6	MHz	

#### AC External Clock Specifications

The following tables list guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and  $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , or 3.0 V to 3.6 V and  $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , respectively. Typical parameters are measured at 5 V and 3.3 V at 25 °C and are for design guidance only.

**Table 25. AC External Clock Specifications**

Symbol	Description	Min	Typ	Max	Units	Notes
$F_{OSCEXT}$	Frequency for USB applications	23.94	24	24.06	MHz	
–	Duty cycle	47	50	53	%	
–	Power up to IMO switch	150	–	–	$\mu\text{s}$	

#### AC Analog Output Buffer Specifications

The following tables list guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and  $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , or 3.0 V to 3.6 V and  $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , respectively. Typical parameters are measured at 5 V and 3.3 V at 25 °C and are for design guidance only.

**Table 26. 5-V AC Analog Output Buffer Specifications**

Symbol	Description	Min	Typ	Max	Units	Notes
$T_{ROB}$	Rising settling time to 0.1%, 1 V Step, 100 pF load Power = Low Power = High	–	–	2.5	$\mu\text{s}$	
		–	–	2.5	$\mu\text{s}$	
$T_{SOB}$	Falling settling time to 0.1%, 1 V Step, 100 pF load Power = Low Power = High	–	–	2.2	$\mu\text{s}$	
		–	–	2.2	$\mu\text{s}$	
$SR_{ROB}$	Rising slew rate (20% to 80%), 1 V Step, 100 pF load Power = Low Power = High	0.65	–	–	V/ $\mu\text{s}$	
		0.65	–	–	V/ $\mu\text{s}$	
$SR_{FOB}$	Falling slew rate (80% to 20%), 1 V Step, 100 pF load Power = Low Power = High	0.65	–	–	V/ $\mu\text{s}$	
		0.65	–	–	V/ $\mu\text{s}$	
$BW_{OBSS}$	Small signal bandwidth, 20 mV <sub>pp</sub> , 3 dB BW, 100 pF load Power = Low Power = High	0.8	–	–	MHz	
		0.8	–	–	MHz	
$BW_{OBSL}$	Large signal bandwidth, 1 V <sub>pp</sub> , 3 dB BW, 100 pF load Power = Low Power = High	300	–	–	kHz	
		300	–	–	kHz	



**Table 27. 3.3-V AC Analog Output Buffer Specifications**

Symbol	Description	Min	Typ	Max	Units	Notes
$T_{ROB}$	Rising settling time to 0.1%, 1 V Step, 100 pF load Power = Low Power = High	— —	— —	3.8 3.8	$\mu\text{s}$ $\mu\text{s}$	
$T_{SOB}$	Falling settling time to 0.1%, 1 V Step, 100 pF load Power = Low Power = High	— —	— —	2.6 2.6	$\mu\text{s}$ $\mu\text{s}$	
$SR_{ROB}$	Rising slew rate (20% to 80%), 1 V Step, 100 pF load Power = Low Power = High	0.5 0.5	— —	— —	$\text{V}/\mu\text{s}$ $\text{V}/\mu\text{s}$	
$SR_{FOB}$	Falling slew rate (80% to 20%), 1 V Step, 100 pF load Power = Low Power = High	0.5 0.5	— —	— —	$\text{V}/\mu\text{s}$ $\text{V}/\mu\text{s}$	
$BW_{OBSS}$	Small signal bandwidth, 20 mV <sub>pp</sub> , 3 dB BW, 100 pF load Power = Low Power = High	0.7 0.7	— —	— —	MHz MHz	
$BW_{OBLS}$	Large signal bandwidth, 1 V <sub>pp</sub> , 3 dB BW, 100 pF load Power = Low Power = High	200 200	— —	— —	kHz kHz	

#### AC Programming Specifications

The following table lists guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and  $-40\text{ }^{\circ}\text{C} \leq T_A \leq 85\text{ }^{\circ}\text{C}$ , or 3.0 V to 3.6 V and  $-40\text{ }^{\circ}\text{C} \leq T_A \leq 85\text{ }^{\circ}\text{C}$ , respectively. Typical parameters are measured at 5 V and 3.3 V at 25 °C and are for design guidance only.

**Table 28. AC Programming Specifications**

Symbol	Description	Min	Typ	Max	Units	Notes
$T_{RSCLK}$	Rise time of SCLK	1	—	20	ns	
$T_{FSCLK}$	Fall time of SCLK	1	—	20	ns	
$T_{SSCLK}$	Data setup time to falling edge of SCLK	40	—	—	ns	
$T_{HSCLK}$	Data hold time from falling edge of SCLK	40	—	—	ns	
$F_{SCLK}$	Frequency of SCLK	0	—	8	MHz	
$T_{ERASEB}$	Flash erase time (Block)	—	10	—	ms	
$T_{WRITE}$	Flash block write time	—	40	—	ms	
$T_{DSCLK}$	Data out delay from falling edge of SCLK	—	—	45	ns	$V_{DD} > 3.6$
$T_{DSCLK3}$	Data out delay from falling edge of SCLK	—	—	50	ns	$3.0 \leq V_{DD} \leq 3.6$
$T_{ERASEALL}$	Flash erase time (Bulk)	—	40	—	ms	Erase all blocks and protection fields at once.
$T_{PROGRAM\_HOT}$	Flash block erase + flash block write time	—	—	100 <sup>[12]</sup>	ms	$0\text{ }^{\circ}\text{C} \leq T_J \leq 100\text{ }^{\circ}\text{C}$
$T_{PROGRAM\_COLD}$	Flash block erase + flash block write time	—	—	200 <sup>[12]</sup>	ms	$-40\text{ }^{\circ}\text{C} \leq T_J \leq 0\text{ }^{\circ}\text{C}$

#### Note

12. For the full industrial range, you must employ a Temperature Sensor User Module (FlashTemp) and feed the result to the temperature argument before writing. Refer to the Flash APIs Application Note, [AN2015 - PSoC® 1 - Reading and Writing PSoC Flash](#) for more information.



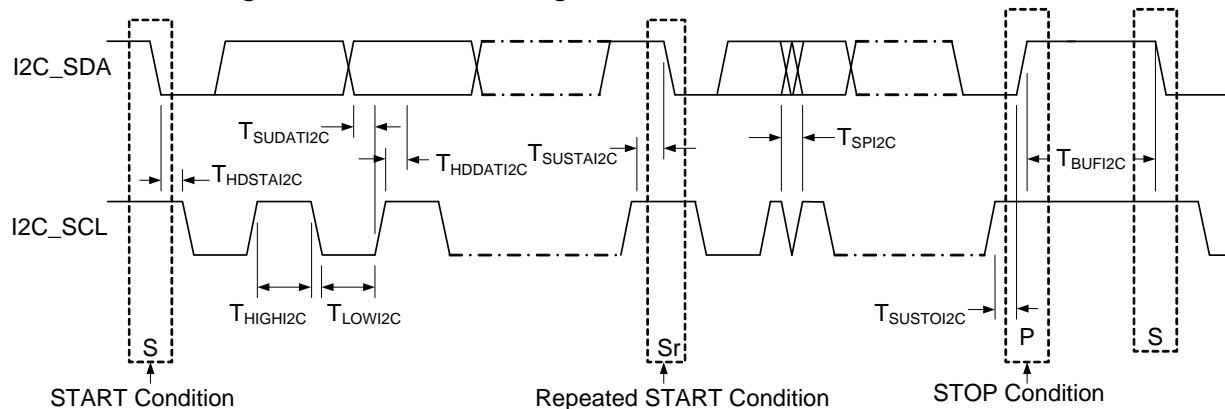
### AC I<sup>2</sup>C Specifications

The following table lists guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and  $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , or 3.0 V to 3.6 V and  $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ , respectively. Typical parameters are measured at 5 V and 3.3 V at 25  $^{\circ}\text{C}$  and are for design guidance only.

**Table 29. AC Characteristics of the I<sup>2</sup>C SDA and SCL Pins for V<sub>DD</sub>**

Symbol	Description	Standard-Mode		Fast-Mode		Units	Notes
		Min	Max	Min	Max		
F <sub>SCL I2C</sub>	SCL clock frequency	0	100	0	400	kHz	
T <sub>HDSTAI2C</sub>	Hold time (repeated) START condition. After this period, the first clock pulse is generated.	4.0	—	0.6	—	μs	
T <sub>LOWI2C</sub>	LOW period of the SCL clock	4.7	—	1.3	—	μs	
T <sub>HIGHI2C</sub>	HIGH period of the SCL clock	4.0	—	0.6	—	μs	
T <sub>SUSTAI2C</sub>	Setup time for a repeated START condition.	4.7	—	0.6	—	μs	
T <sub>HDDATI2C</sub>	Data hold time	0	—	0	—	μs	
T <sub>SUDATI2C</sub>	Data setup time	250	—	100 <sup>[13]</sup>	—	ns	
T <sub>SUSTOI2C</sub>	Setup time for STOP condition	4.0	—	0.6	—	μs	
T <sub>BUFI2C</sub>	Bus free time between a STOP and START condition	4.7	—	1.3	—	μs	
T <sub>SPI2C</sub>	Pulse width of spikes are suppressed by the input filter.	—	—	0	50	ns	

**Figure 8. Definition for Timing for Fast-/Standard-Mode on the I<sup>2</sup>C Bus**



#### Note

13. A Fast-Mode I<sup>2</sup>C-bus device can be used in a Standard-Mode I<sup>2</sup>C-bus system, but the requirement  $t_{\text{SU, DAT}} \geq 250$  ns must then be met. This will automatically be the case if the device does not stretch the LOW period of the SCL signal. If such device does stretch the LOW period of the SCL signal, it must output the next data bit to the SDA line  $t_{\text{rmax}} + t_{\text{SU, DAT}} = 1000 + 250 = 1250$  ns (according to the Standard-Mode I<sup>2</sup>C-bus specification) before the SCL line is released.



## Development Tools

### Software

This section presents the development tools available for all current PSoC device families including the CY8CLED04 EZ-Color.

#### *PSoC Designer™*

At the core of the PSoC development software suite is PSoC Designer, used to generate PSoC firmware applications. PSoC Designer is available free of charge at <http://www.cypress.com/psocdesigner> and includes a free C compiler.

#### *PSoC Programmer*

Flexible enough to be used on the bench in development, yet suitable for factory programming, PSoC Programmer works either as a standalone programming application or it can operate directly from PSoC Designer. PSoC Programmer software is compatible with both PSoC ICE-Cube In-Circuit Emulator and PSoC MiniProg. PSoC programmer is available free of charge at <http://www.cypress.com/psocprogrammer>.

### Evaluation Tools

All evaluation tools can be purchased from the Cypress Online Store.

#### *CY3210-MiniProg1*

The [CY3210-MiniProg1 kit](#) allows a user to program PSoC devices via the MiniProg1 programming unit. The MiniProg is a small, compact prototyping programmer that connects to the PC via a provided USB 2.0 cable. The kit includes:

- MiniProg Programming Unit
- MiniEval Socket Programming and Evaluation Board
- 28-Pin CY8C29466-24PXI PDIP PSoC Device Sample
- 28-Pin CY8C27443-24PXI PDIP PSoC Device Sample
- PSoC Designer Software CD
- Getting Started Guide
- USB 2.0 Cable

#### *CY3210-PSoCEval1*

The [CY3210-PSoCEval1 kit](#) features an evaluation board and the MiniProg1 programming unit. The evaluation board includes

an LCD module, potentiometer, LEDs, and plenty of bread-boarding space to meet all of your evaluation needs. The kit includes:

- Evaluation Board with LCD Module
- MiniProg Programming Unit
- 28-Pin CY8C29466-24PXI PDIP PSoC Device Sample (2)
- PSoC Designer Software CD
- Getting Started Guide
- USB 2.0 Cable

### Device Programmers

All device programmers can be purchased from the Cypress Online Store.

#### *CY3216 Modular Programmer*

The [CY3216 Modular Programmer kit](#) features a modular programmer and the MiniProg1 programming unit. The modular programmer includes three programming module cards and supports multiple Cypress products. The kit includes:

- Modular Programmer Base
- 3 Programming Module Cards
- MiniProg Programming Unit
- PSoC Designer Software CD
- Getting Started Guide
- USB 2.0 Cable

#### *CY3207ISSP In-System Serial Programmer (ISSP)*

The [CY3207ISSP](#) is a production programmer. It includes protection circuitry and an industrial case that is more robust than the MiniProg in a production-programming environment.

**Note** CY3207ISSP needs special software and is not compatible with PSoC Programmer. The kit includes:

- CY3207 Programmer Unit
- PSoC ISSP Software CD
- 110 ~ 240 V Power Supply, Euro-Plug Adapter
- USB 2.0 Cable
-



## Accessories (Emulation and Programming)

**Table 30. Emulation and Programming Accessories**

Part #	Pin Package	Flex-Pod Kit <sup>[16]</sup>	Adapter <sup>[17]</sup>
CY8CLED04-68LTXI	68-pin QFN	CY3250-LED04	Adapters can be found at <a href="http://www.emulation.com">http://www.emulation.com</a> .

### Third Party Tools

Several tools have been specially designed by the following third-party vendors to accompany PSoC devices during development and production. Specific details for each of these tools can be found at <http://www.cypress.com> under Design Support >> Development Kits/Boards.

### Build a PSoC Emulator into Your Board

For details on how to emulate your circuit before going to volume production using an on-chip debug (OCD) non-production PSoC device, see Application Note *Debugging - Build a PSoC Emulator into Your Board* - [AN2323](#).



## Acronyms

### Acronyms Used

The following table lists the acronyms that are used in this document.

Acronym	Description	Acronym	Description
AC	alternating current	MAC	multiply-accumulate
ADC	analog-to-digital converter	MIPS	million instructions per second
API	application programming interface	PCB	printed circuit board
CMOS	complementary metal oxide semiconductor	PDIP	plastic dual-in-line package
CPU	central processing unit	PGA	programmable gain amplifier
CRC	cyclic redundancy check	POR	power-on reset
CT	continuous time	PPOR	precision power-on reset
DAC	digital-to-analog converter	PRS	pseudo-random sequence
DC	direct current	PrISM™	precise illumination signal modulation
DTMF	dual-tone multi-frequency	PSoC®	Programmable System-on-Chip™
EEPROM	electrically erasable programmable read-only memory	PWM	pulse-width modulator
GPIO	general purpose I/O	QFN	quad flat no leads
I/O	input/output	SAR	successive approximation register
ICE	in-circuit emulator	SRAM	static random-access memory
IDE	integrated development environment	SC	switched capacitor
ILO	internal low speed oscillator	SLIMO	slow IMO
IMO	internal main oscillator	SOIC	small-outline integrated circuit
IrDA	infrared data association	SPIT™	serial peripheral interface
ISSP	In-System Serial Programming	SROM	supervisory read-only memory
LCD	liquid crystal display	UART	universal asynchronous receiver / transmitter
LED	light-emitting diode	USB	universal serial bus
LPC	low power comparator	WDT	watchdog timer
LVD	low-voltage detect	XRES	external reset

## Reference Documents

*Design Aids – Reading and Writing PSoC® Flash – AN2015* (001-40459)

*Understanding Datasheet Jitter Specifications for Cypress Timing Products – AN5054* (001-14503)

*Application Notes for Surface Mount Assembly of Amkor's MicroLeadFrame (MLF) Packages* – available at <http://www.amkor.com>



## Glossary (continued)

emulator	Duplicates (provides an emulation of) the functions of one system with a different system, so that the second system appears to behave like the first system.
external reset (XRES)	An active high signal that is driven into the PSoC device. It causes all operation of the CPU and blocks to stop and return to a pre-defined state.
flash	An electrically programmable and erasable, non-volatile technology that provides users with the programmability and data storage of EPROMs, plus in-system erasability. Non-volatile means that the data is retained when power is off.
Flash block	The smallest amount of Flash ROM space that may be programmed at one time and the smallest amount of Flash space that may be protected. A Flash block holds 64 bytes.
frequency	The number of cycles or events per unit of time, for a periodic function.
gain	The ratio of output current, voltage, or power to input current, voltage, or power, respectively. Gain is usually expressed in dB.
I <sup>2</sup> C	A two-wire serial computer bus by Philips Semiconductors (now NXP Semiconductors). I <sup>2</sup> C is an Inter-Integrated Circuit. It is used to connect low-speed peripherals in an embedded system. The original system was created in the early 1980s as a battery control interface, but it was later used as a simple internal bus system for building control electronics. I <sup>2</sup> C uses only two bi-directional pins, clock and data, both running at +5V and pulled high with resistors. The bus operates at 100 kbits/second in standard mode and 400 kbits/second in fast mode.
ICE	The in-circuit emulator that allows users to test the project in a hardware environment, while viewing the debugging device activity in a software environment (PSoC Designer).
input/output (I/O)	A device that introduces data into or extracts data from a system.
interrupt	A suspension of a process, such as the execution of a computer program, caused by an event external to that process, and performed in such a way that the process can be resumed.
interrupt service routine (ISR)	A block of code that normal code execution is diverted to when the M8C receives a hardware interrupt. Many interrupt sources may each exist with its own priority and individual ISR code block. Each ISR code block ends with the RETI instruction, returning the device to the point in the program where it left normal program execution.
jitter	<ol style="list-style-type: none"> <li>1. A misplacement of the timing of a transition from its ideal position. A typical form of corruption that occurs on serial data streams.</li> <li>2. The abrupt and unwanted variations of one or more signal characteristics, such as the interval between successive pulses, the amplitude of successive cycles, or the frequency or phase of successive cycles.</li> </ol>
low-voltage detect (LVD)	A circuit that senses V <sub>DD</sub> and provides an interrupt to the system when V <sub>DD</sub> falls lower than a selected threshold.
M8C	An 8-bit Harvard-architecture microprocessor. The microprocessor coordinates all activity inside a PSoC by interfacing to the flash, SRAM, and register space.
master device	A device that controls the timing for data exchanges between two devices. Or when devices are cascaded in width, the master device is the one that controls the timing for data exchanges between the cascaded devices and an external interface. The controlled device is called the <i>slave device</i> .



## Document History Page

Document Title: CY8CLED04 EZ-Color™ HB LED Controller Document Number: 001-13108				
Rev.	ECN No.	Orig. of Change	Submission Date	Description of Change
**	1148504	SFVTMP3	See ECN	New document.
*A	2657959	DPT/PYRS	02/11/2009	Added package diagram 001-09618 and updated Ordering Information table
*B	2794355	XBM	10/28/2009	Added <a href="#">"Contents"</a> on page 3. Updated <a href="#">"Development Tools"</a> on page 7. Corrected FCPU1 and FCPU2 parameters in <a href="#">"AC Chip-Level Specifications"</a> on page 29.
*C	2850593	FRE/DSG/HMT	01/14/2010	Removed pruned/obsolete parts (CY8CLED04-68LFXI). Updated DC GPIO, AC Chip-Level, and AC Programming Specifications as follows: Modified TWRITE specifications. Replaced TRAMP time) specification with SRPOWER_UP (slew rate) specification. Added note to Flash Endurance specification. Added IOH, IOL, DCILO, F32K_U, TPOWERUP, TERASEALL, TPROGRAM_HOT, and TPROGRAM_COLD specifications. Corrected the Pod Kit part numbers. Updated <a href="#">Development Tools</a> . Updated copyright and <a href="#">Sales, Solutions, and Legal Information</a> URLs. Updated 68-Pin QFN (Sawn Type) package diagram.
*D	2900748	CGX	03/31/2010	Removed inactive parts from Ordering Information table. Added active parts in Ordering Information table.
*E	3111560	NJF	12/15/10	Added DC I <sup>2</sup> C Specifications table. Added F <sub>32K_U</sub> max limit. Added Tjit_IMO specification, removed existing jitter specifications. Updated Units of Measure, Acronyms, Glossary, and References sections. Updated solder reflow specifications. No specific changes were made to AC Digital Block Specifications table and I <sup>2</sup> C Timing Diagram. They were updated for clearer understanding. Updated Figure 6 since the labelling for y-axis was incorrect. Template and styles update.
*F	3283777	DIVA	07/13/11	Updated <a href="#">Getting Started</a> , <a href="#">Development Tools</a> , and <a href="#">Designing with PSoC Designer</a> . Removed obsolete kits. Removed reference to obsolete spec AN2012.